

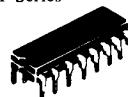
HM51256 Series

262144-word × 1-bit CMOS Dynamic Random Access Memory

■FEATURE

- 262, 144 word x 1 bit DRAM
- Double layer Poly-Si/Polycide Process, high performance CMOS
- Power supply voltage: 5V ± 10%
- Access time
 - Row access time: 85/100/120/150ns
 - Address access time: 40/45/55/70ns
- Cycle time
 - Random read/write cycle time: 155/180/210/250ns
 - High speed page mode cycle time: 50/55/65/80ns
- Lower power
 - Standby: 11mW (TTL Level)
 - 1.1mW (CMOS Level: L-version)
 - Active: 385/330/275/220mW
- Refresh: 256 cycles/4ms
 - 256 cycles/32ms (L-version)
- Refresh function: $\overline{\text{RAS}}$ only refresh, $\overline{\text{CAS}}$ before $\overline{\text{RAS}}$ refresh, Hidden refresh
- High speed page mode capability
- Edge triggered write capability
- Fast $\overline{\text{CAS}}$ output control

HM51256P Series
HM51256LP Series



(DP-16B)

HM51256CP Series
HM51256LCP Series



(CP-18)

HM51256ZP Series
HM51256LZP Series



(ZP-16)

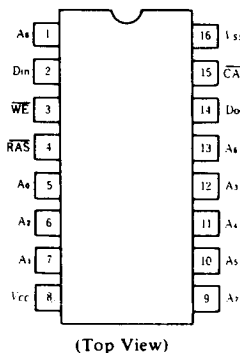
■ ORDERING INFORMATION

Type No.	Access Time	Package
HM51256P-8	85ns	300 mil 16 pin Plastic DIP
HM51256P-10	100ns	
HM51256P-12	120ns	
HM51256P-15	150ns	
HM51256CP-8	85ns	18 Pin PLCC
HM51256CP-10	100ns	
HM51256CP-12	120ns	
HM51256CP-15	150ns	
HM51256LP-8	85ns	300 mil 16 pin Plastic DIP
HM51256LP-10	100ns	
HM51256LP-12	120ns	
HM51256LP-15	150ns	
HM51256LCP-8	85ns	18 pin PLCC
HM51256LCP-10	100ns	
HM51256LCP-12	120ns	
HM51256LCP-15	150ns	
HM51256ZP-8	85ns	16 pin Plastic ZIP
HM51256ZP-10	100ns	
HM51256ZP-12	120ns	
HM51256ZP-15	150ns	
HM51256LZP-8	85ns	16 pin Plastic ZIP
HM51256LZP-10	100ns	
HM51256LZP-12	120ns	
HM51256LZP-15	150ns	



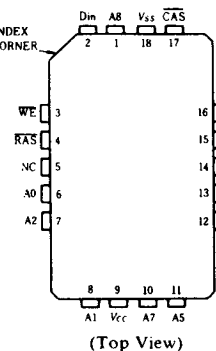
PIN ARRANGEMENT

HM51256P Series HM51256LP Series



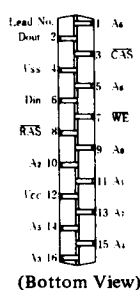
(Top View)

HM51256CP Series HM51256LCP Series



(Top View)

HM51256ZP Series HM51256LZP Series



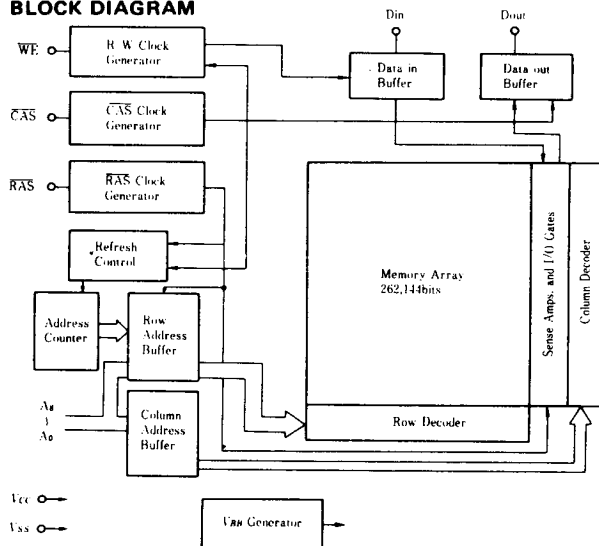
(Bottom View)

$A_0 - A_7$	Address Inputs
CAS	Column Address Strobe
Din	Data In
Dout	Data Out
RAS	Row Address Strobe
WE	Read/Write Input
V_{CC}	Power (+5V)
V_{SS}	Ground
$A_8 - A_{17}$	Refresh Address Inputs

ABSOLUTE MAXIMUM RATINGS

Voltage on any pin relative to V_{SS} -1V to +7V
 Operating temperature, T_a (Ambient) 0°C to +70°C
 Storage temperature -55°C to +125°C
 Short circuit output current 50mA
 Power dissipation 1W

BLOCK DIAGRAM



RECOMMENDED DC OPERATING CONDITIONS ($T_a = 0$ to +70°C)

Parameter	Symbol	min	typ	max	Unit	Note
Supply Voltage	V_{CC}	4.5	5.0	5.5	V	1
Input High Voltage	V_{IH}	2.4	—	6.5	V	1
Input Low Voltage	V_{IL}	-1.0	—	0.8	V	1

Note) 1. All voltages referenced to V_{SS}



DC ELECTRICAL CHARACTERISTICS ($T_a=0$ to $+70^{\circ}\text{C}$, $V_{CC}=5\text{V}\pm 10\%$, $V_{SS}=0\text{V}$)

Parameter	Symbol	HM51256-8		HM51256-10		HM51256-12		HM51256-15		Unit	Notes
		min	max	min	max	min	max	min	max		
Operating Current (RAS, CAS Cycling, $t_{RC} = \text{min}$)	I_{CC1}	—	70	—	60	—	50	—	40	mA	1
Standby Current (RAS = V_{IH} , Dout = High Impedance)	I_{CC2}	—	2	—	2	—	2	—	2	mA	
Refresh Current (RAS only Refresh, $t_{RC} = \text{min}$)	I_{CC3}	—	70	—	60	—	50	—	40	mA	
Standby Current (RAS = V_{IH} , Dout Enable)	I_{CC4}	—	6	—	6	—	6	—	6	mA	1
Refresh Current (CAS before RAS Refresh, $t_{RC} = \text{min}$)	I_{CC5}	—	60	—	55	—	45	—	35	mA	
High Speed Page Mode Supply Current (RAS = V_{IH} , CAS Cycling, $t_{RC} = \text{min}$)	I_{CC6}	—	70	—	60	—	50	—	40	mA	1
Standby Current (RAS, CAS = $V_{CC}-0.2\text{V}$)	I_{CC7}	—	200	—	200	—	200	—	200	μA	2
Input leakage ($0 < V_{in} < 7\text{V}$)	I_{LI}	-10	10	-10	10	-10	10	-10	10	μA	
Output leakage ($0 < V_{out} < 7\text{V}$, Dout = Disable)	I_{LO}	-10	10	-10	10	-10	10	-10	10	μA	
Output levels High ($I_{out} = -5\text{mA}$)	V_{OH}	2.4	V_{CC}	2.4	V_{CC}	2.4	V_{CC}	2.4	V_{CC}	V	
Output levels Low ($I_{out} = 4.2\text{mA}$)	V_{OL}	0	0.4	0	0.4	0	0.4	0	0.4	V	

Notes: 1. I_{CC} depends on output loading condition when the device is selected. I_{CC} max. is specified at the output open condition.
2. This specification is guaranteed only for L-version.

CAPACITANCE ($V_{CC}=5\text{V}\pm 10\%$, $T_a=25^{\circ}\text{C}$)

Parameter		Symbol	typ	max	Unit	Notes
Input Capacitance	Address, Data-in	C_{II}	—	5	pF	1
	Clocks	C_{II}	—	7		1
Output Capacitance	Data out	C_{IO}	—	7		1, 2

Notes: 1. Capacitance measured with Boonton Meter or effective capacitance measuring method.
2. CAS = V_{IH} to disable Dout.

ELECTRICAL CHARACTERISTICS AND RECOMMENDED AC OPERATING CONDITIONS

($T_a=0$ to $+70^{\circ}\text{C}$, $V_{CC}=5\text{V}\pm 10\%$, $V_{SS}=0\text{V}$)

Read, Write, Read-Modify-Write and Refresh Cycles (Common Parameter)

Parameter	Symbol	HM51256-8		HM51256-10		HM51256-12		HM51256-15		Unit	Notes
		min	max	min	max	min	max	min	max		
Random Read or Write Cycle Time	t_{RC}	155	—	180	—	210	—	250	—	ns	
RAS Precharge Time	t_{RP}	60	—	70	—	80	—	90	—	ns	
RAS Pulse Width	t_{RAS}	55	10000	65	10000	75	10000	95	10000	ns	
CAS Pulse Width	t_{CAS}	25	—	25	—	30	—	35	—	ns	
Column Address Set-up Time	t_{ASC}	0	—	0	—	0	—	0	—	ns	
Column Address Hold Time	t_{CAH}	15	—	20	—	25	—	30	—	ns	
Column Address Hold Time to RAS	t_{AR}	60	—	75	—	90	—	110	—	ns	
RAS to CAS Delay Time	t_{RCD}	20	60	25	75	25	90	30	115	ns	8
RAS to Column Address Delay Time	t_{RAD}	15	45	20	55	20	65	25	80	ns	9
RAS Hold Time	t_{RSH}	20	—	25	—	30	—	35	—	ns	
CAS Hold Time	t_{CSH}	85	—	100	—	120	—	150	—	ns	
CAS to RAS Precharge Time	t_{CRP}	10	—	10	—	10	—	10	—	ns	
Row Address Set-up Time	t_{ASR}	0	—	0	—	0	—	0	—	ns	
Row Address Hold Time	t_{RAH}	10	—	15	—	15	—	20	—	ns	
Transition Time (Rise and Fall)	t_T	3	50	3	50	3	50	3	50	ns	7
Refresh Period	t_{REF}	—	4	—	4	—	4	—	4	ms	
		—	32	—	32	—	32	—	32	ms	21

Read Cycle

Parameter	Symbol	HM51256-8		HM51256-10		HM51256-12		HM51256-15		Unit	Notes
		min	max	min	max	min	max	min	max		
Access Time from RAS	t_{RAC}	—	85	—	100	—	120	—	150	ns	2, 3
Access Time from CAS	t_{CAC}	—	25	—	25	—	30	—	35	ns	3, 4
Access Time from Address	t_{AA}	—	40	—	45	—	55	—	70	ns	3, 5, 14
Read Command Set-up Time	t_{RCS}	0	—	0	—	0	—	0	—	ns	
Read Command Hold Time to CAS	t_{RCH}	0	—	0	—	0	—	0	—	ns	
Read Command Hold Time to RAS	t_{RRH}	10	—	10	—	10	—	10	—	ns	
Column Address to RAS Lead Time	t_{RAL}	40	—	45	—	55	—	70	—	ns	
Output Buffer Turn-off Time	t_{OFF}	0	20	0	25	0	30	0	35	ns	6



● Write Cycle

Parameter	Symbol	HM51256-8		HM51256-10		HM51256-12		HM51256-15		Unit	Notes
		min	max	min	max	min	max	min	max		
Write Command Set-up Time	t_{wcs}	0	—	0	—	0	—	0	—	ns	10
Write Command Hold Time	t_{wch}	20	—	25	—	30	—	35	—	ns	
Write Command Hold Time to RAS	t_{wcr}	65	—	80	—	95	—	115	—	ns	
Write Command Pulse Width	t_{wP}	15	—	20	—	25	—	30	—	ns	
Write Command to RAS Lead Time	t_{wL}	20	—	25	—	30	—	35	—	ns	
Write Command to CAS Lead Time	t_{wCL}	20	—	25	—	30	—	35	—	ns	
Data-in Set-up Time	t_{DS}	0	—	0	—	0	—	0	—	ns	11
Data-in Hold Time	t_{DH}	15	—	20	—	25	—	30	—	ns	10, 11
Data-in Hold Time to RAS	t_{DHR}	60	—	75	—	90	—	110	—	ns	

● Read-Modify-Write Cycle

Parameter	Symbol	HM51256-8		HM51256-10		HM51256-12		HM51256-15		Unit	Notes
		min	max	min	max	min	max	min	max		
Read-Write Cycle Time	t_{rwc}	180	—	210	—	245	—	290	—	ns	
RAS to $\overline{WE}$ Delay Time	t_{rwD}	85	—	100	—	120	—	150	—	ns	10
CAS to $\overline{WE}$ Delay Time	t_{cwD}	20	—	25	—	30	—	35	—	ns	10
Column Address to $\overline{WE}$ Delay Time	t_{awD}	40	—	45	—	55	—	70	—	ns	10

● Refresh Cycle

Parameter	Symbol	HM51256-8		HM51256-10		HM51256-12		HM51256-15		Unit	Notes
		min	max	min	max	min	max	min	max		
CAS Set-up Time (CAS before RAS Refresh)	t_{csr}	10	—	10	—	10	—	10	—	ns	
CAS Hold Time (CAS before RAS Refresh)	t_{chr}	10	—	10	—	10	—	10	—	ns	
RAS Precharge to CAS Hold Time	t_{rpc}	15	—	15	—	15	—	15	—	ns	

● High Speed Page Mode Cycle

Parameter	Symbol	HM51256-8		HM51256-10		HM51256-12		HM51256-15		Unit	Notes
		min	max	min	max	min	max	min	max		
High Speed Page Mode Cycle Time	t_{pc}	50	—	55	—	65	—	80	—	ns	18, 20
High Speed Page Mode RAS Pulse Width	t_{rAPC}	55	75000	65	75000	75	75000	95	75000	ns	19
RAS to Second WE Delay Time	t_{rsu}	90	—	105	—	125	—	155	—	ns	
CAS Precharge Time	t_{cp}	10	—	15	—	20	—	20	—	ns	
Write Invalid Time	t_{wi}	10	—	10	—	15	—	15	—	ns	
Access Time from Column Precharge Time	t_{cap}	—	45	—	50	—	60	—	75	ns	20

● High Speed Page Mode Read-Modify-Write Cycle

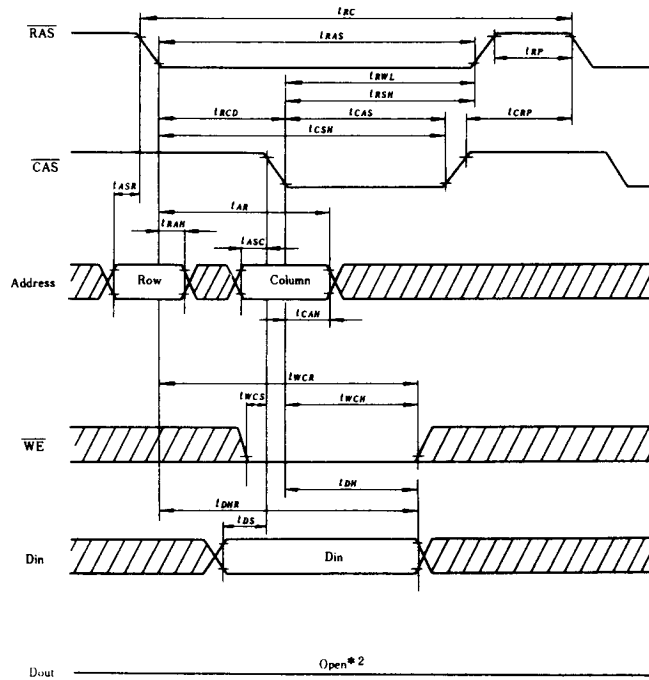
Parameter	Symbol	HM51256-8		HM51256-10		HM51256-12		HM51256-15		Unit	Notes
		min	max	min	max	min	max	min	max		
High Speed Page Mode Cycle Time on Read-Write	t_{rwpc}	85	—	95	—	115	—	145	—	ns	12
Access Time from Previous WE	t_{rwa}	—	80	—	90	—	110	—	140	ns	3, 13
Previous WE to Column Address Delay Time	t_{rad}	20	40	25	45	30	55	35	70	ns	15

Notes: 1. AC measurements assume $t_T = 5ns$.2. Assumes that $t_{RCD} \leq t_{RCD}(\max)$ and $t_{RAD} \leq t_{RAD}(\max)$. If t_{RCD} or t_{RAD} is greater than the maximum recommended value shown in this table t_{RAC} exceeds the value shown.

3. Measured with a load circuit equivalent to 2TTL loads and 100pF.

4. Assumes that $t_{RCD} \geq t_{RCD}(\max)$ and $t_{RAD} \leq t_{RAD}(\max)$.5. Assumes that $t_{RCD} \leq t_{RCD}(\max)$ and $t_{RAD} \geq t_{RAD}(\max)$.6. $t_{OFF}(\max)$ is defined as the time at which the output achieves the open circuit condition and is not referenced to output voltage levels.

● Write Cycle



● Read Modify Write Cycle

